



ENGINEERING DEPT.

PRODUCT SPECIFICATION

SPEC.NO.: SPCI035F

REVISIONS | ECNT120150

For CI11 Series Connector System

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1. SCOPE:

This specification contains the test requirement of subject connectors when tested under the condition and procedure with terminals crimped on the specified maximum size wire

2. APPLICABLE STANDARDS:

MIL - STD - 202 Methods for test of connectors for electronic equipment

EIA - 364 Test methods for electrical connectors

J-STD-020 Resistance to soldering Temperature for through hole Mounted Devices Test methods for electronic components ,LEAD-FREE soldering Part SS-00254

design standards

3. APPLICABLE SERIES NO: CI11 Dual Row Series

4. SHAPE, CONSTRUCTION AND DIMENSIONS See attached drawings

5. MATERIALS

See attached drawings

6. ACCOMMODATED P.C.BOARD

6.1 Thickness: 0.6 mm (.024") ~ 1.2 mm (.047"),1.6mm(.063")

6.2 P.C. Board Layout: See attached drawings

REVIEWED: <u>Eisley</u> APPROVED: <u>Sun</u> VERIFIED: <u>Michelle</u>.





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7. ELECTRICAL PERFORMANCE:

	ITEM	TEST CONDITION	REQUIREMENT
7.1	Rated current and voltage		1.0A AC (r.m.s.)/DC
			(AWG#28)
			50V AC (r.m.s.)/DC
7.2	Contact resistance	Dry circuit of DC 20 mV max., 100 mA max.(JIS C5402 5.4)	Less than $20 \text{ m}\Omega$
7.3	Dielectric strength	When applied AC 500 V 1 minute between adjacent terminal(JIS C5402 5.2/MIL-STD 202 method 302 Cond. B)	No change
7.4	Insulation resistance	When applied DC 500 V between adjacent terminal or ground (JIS C5402 5.2/MIL-STD 202 method 301)	More than $100 \text{ M}\Omega$

8. MECHANICAL PERFORMANCE:

	ITEM	TEST CONDITION	REQUIREMENT
8.1	Wire size	Specified wire size	Accepts AWG#28~#32
8.2	Terminal crimp Tensile strength	When crimped AWG#28 size wire	More than 1.3 Kgf
		When crimped AWG#30 size wire	More than 0.8 Kgf
		When crimped AWG#32 size wire	More than 0.6 Kgf
8.3	Terminal insertion force	Insertion speed 25± 3 mm per minute into housing	Less than 500 gram
8.4	Terminal retaining force in insulator	Retention speed 25± 3 mm per minute from housing	More than 700 gram
8.5	Single contact insertion force	Measure force to insertion using pin of header at speed 25± 3 mm per minute	Less than 200 gram
8.6	Single contact withdrawal force	Measure force to withdrawal using pin of header at speed 25± 3 mm per minute	More than 50 gram
8.7	Durability	Connector shall be subjected to 30 cycles of insertion and withdrawal (repeatedly by the rate of 10 cycles per minute)	Contact resistance: Less than twice of initial
8.8	Pin retention force	Push pin from insulator base at speed	More than 0.50 Kgf
		25± 3 mm per minute	





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9. ENVIRONMENTAL PERFORMANCE:

	ITEM	TEST CONDITION	REQUIREMENT
9.1	Temperature rise	Then carried the rated current (UL 498)	30°C max.
9.2	Vibration	1.5 mm 10-55-10 HZ / minute each 2 hours for X, Y and Z directions (MIL-STD-202,method 201A)	Appearance: No damage Discontinuity: 1 micro second max.
9.3	Solder ability	Tin-Lead Process:	Minimum:
	J	Soldering time: 5 ± 0.5 second	90% of immersed area
		Soldering pot: 230 ± 5°C	
		Lead-Free Process:	
		Soldering time: 3 ± 0.5 second	
		Soldering pot: 245 ± 5°C	
9.4	Resistance to soldering	SMT Type Tin-Lead Process:	No damage
	heat	Refer Reflow temperature profile(11.1)	
		Soldering time: 10 second Max.	
		Soldering pot: 230 ± 5 °C	
		SMT Type Lead-Free Process:	
		Soldering time: 20 second Max.	
		Soldering pot: 250~260°C	
		Refer Reflow temperature profile(11.2)	
9.5	Heat aging	85 ± 2°C, 96 hours(JIS C0021/MIL-STD-202,method 108A,condition A)	No damage Contact resistance: Less than twice of initial
9.6	Humidity	60 ± 2°C, 90-95% RH, 96 hours measurement must be taken within 30 min. after tested (JIS C0020/MIL-STD-202, method 103 B, condition B)	Appearance: No damage Contact resistance: Less than twice of initial Dielectric strength: To pass Para 7-4
9.7	Temperature cycling	Five cycle consists of: (1)-25 +0 °C, 30 min. (2)Room temp. 10-15 min. (3) 85 +3 °C, 30 min. (4)Room temp. 10-15 min.	Appearance: No damage Contact resistance: Less than twice of initial





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	ITEM	TEST CONDITION	REQUIREMENT
9.8	Salt spray	Temperature: 35 ± 3°C	Appearance: No damage
		Solution: 5 ± 1%	Contact resistance:
		Spray time: 48 ± 4 hours	Less than twice of initial
		(Stamping before plated)	
		Spray time: 24 ± 4 hours	
		(Stamping after plated)	
		Mate connectors and expose to the following salt mist conditions. Upon completion of the exposure period, salt deposits shall be removed by a gentle wash or dip in running water and dried naturally, after which the specified measurements shall be performed.	
		The specimens shall be suspended from the top using waxed twine, string or nylon thread.	
		The test only define the plating area, without plating area (as copper cross section) will not be defined.	
		(EIA 364-26B / MIL-STD-202 Method 101)	

10. AMBIENT TEMPERATURE RANGE: -25 to +85°C





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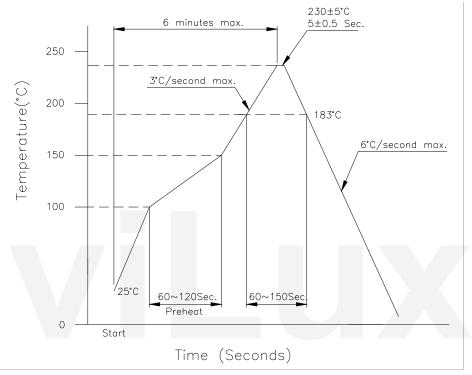
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11. Recommended IR Reflow Temperature Profile:

11.1 Using Typical Solder Paste



11.2 Using Lead-Free Solder Paste

